International Rectifier

- Advanced Process Technology
- Surface Mount (IRFZ46NS)
- Low-profile through-hole (IRFZ46NL)
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

Description

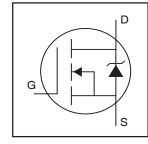
Advanced HEXFET® Power MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

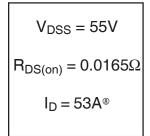
The D^2 Pak is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The D^2 Pak is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.

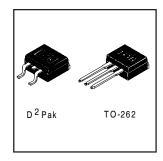
The through-hole version (IRFZ46NL) is available for low-profile applications.

IRFZ46NSPbF IRFZ46NLPbF

HEXFET® Power MOSFET







Absolute Maximum Ratings

	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V ^⑤	53 ®	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V ^⑤	37	Α
I _{DM}	Pulsed Drain Current ① ⑤	180	
P _D @T _A = 25°C	Power Dissipation	3.8	W
$P_{D} @ T_{C} = 25^{\circ}C$	Power Dissipation	107	W
	Linear Derating Factor	0.71	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
I _{AR}	Avalanche Current①	28	А
E _{AR}	Repetitive Avalanche Energy①	11	mJ
dv/dt	Peak Diode Recovery dv/dt 3 5	5.0	V/ns
T _J	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		∞
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case		1.4	00/14/
R _{eJA}	Junction-to-Ambient (PCB Mounted, steady-state)**		40	°C/W

IRFZ46NS/LPbF

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.057		V/°C	Reference to 25°C, I _D =1mA ^⑤
R _{DS(on)}	Static Drain-to-Source On-Resistance			.0165	Ω	V _{GS} =10V, I _D = 28A ④
V _{GS(th)}	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
9 _{fs}	Forward Transconductance	19			S	V _{DS} = 25V, I _D = 28A⊕⑤
loco	Drain-to-Source Leakage Current			25	μA	$V_{DS} = 55V$, $V_{GS} = 0V$
I _{DSS}	Brain to Gource Leakage Guneric			250	μΑ	$V_{DS} = 44V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
1	Gate-to-Source Forward Leakage			100	nA	V _{GS} = 20V
I _{GSS}	Gate-to-Source Reverse Leakage			-100	^	V _{GS} = -20V
Qg	Total Gate Charge			72		I _D = 28A
Q _{gs}	Gate-to-Source Charge			11	nC	$V_{DS} = 44V$
Q _{gd}	Gate-to-Drain ("Miller") Charge			26		V_{GS} = 10V, See Fig. 6 and 13 \oplus \odot
t _{d(on)}	Turn-On Delay Time		14			V _{DD} = 28V
t _r	RiseTime		76		ns	$I_D = 28A$
t _{d(off)}	Turn-Off Delay Time		52		115	$R_G = 12\Omega$
t _f	FallTime		57			$R_D = 0.98\Omega$, See Fig. 10 \oplus \odot
L _S	Internal Source Inductance		7.5		- nH	Between lead,
						and center of die contact
C _{iss}	Input Capacitance		1696			$V_{GS} = 0V$
Coss	Output Capacitance		407		рF	$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		110			$f = 1.0MHz$, See Fig. 5 \circ
E _{AS}	Single Pulse Avalanche Energy ②		5836	152⑦		I _{AS} = 28A, L = 389mH

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current			EO		MOSFET symbol
	(Body Diode)		53	A	showing the	
I _{SM}	Pulsed Source Current			400	''	integral reverse
	(Body Diode) ①			180		p-n junction diode.
V _{SD}	Diode Forward Voltage			1.3	V	T _J = 25°C, I _S = 28A, V _{GS} = 0V ④
t _{rr}	Reverse Recovery Time		67	101	ns	$T_J = 25^{\circ}C, I_F = 28A$
Q _{rr}	Reverse Recovery Charge		208	312	nC	di/dt = 100A/µs ④⑤
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)				

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- $$\label{eq:starting} \begin{split} \textcircled{2} & \text{Starting T}_J = 25^{\circ}\text{C}, \, L = 389 \mu\text{H} \\ & \text{R}_G = 25\Omega, \, \text{I}_{AS} = 28\text{A}. \, \, \text{(See Figure 12)} \end{split}$$
- $\label{eq:loss} \begin{array}{l} \Im \ I_{SD} \leq 28A, \ di/dt \leq 220A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \\ T_{J} \leq 175 ^{\circ}C. \end{array}$
- 4 Pulse width $\leq 400 \mu s$; duty cycle $\leq 2\%$.
- ⑤ Uses IRFZ46N data and test conditions.
- ⑤ This is a typical value at device destruction and represents operation outside rated limits.
- $\ensuremath{{\mbox{$\bigcirc$}}}$ This is a calculated value limited to TJ = 175°C.
- Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 39A.

^{**} When mounted on 1" square PCB (FR-4 or G-10 Material).
For recommended footprint and soldering techniques refer to application note #AN-994.

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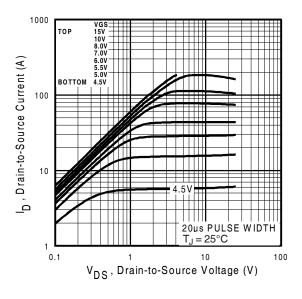


Fig 1. Typical Output Characteristics

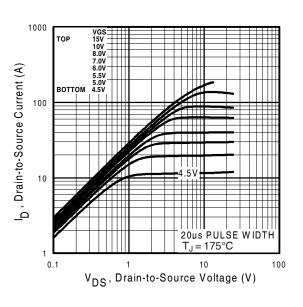


Fig 2. Typical Output Characteristics

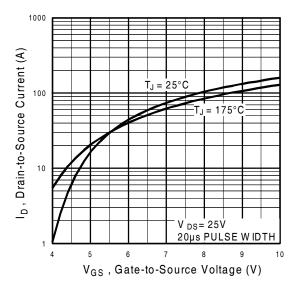


Fig 3. Typical Transfer Characteristics

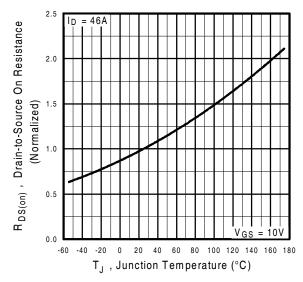


Fig 4. Normalized On-Resistance Vs. Temperature

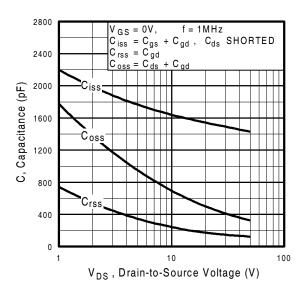


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

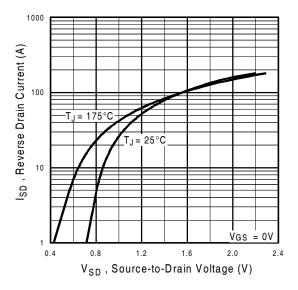


Fig 7. Typical Source-Drain Diode Forward Voltage

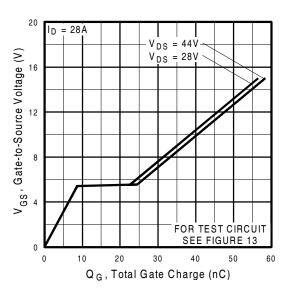


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

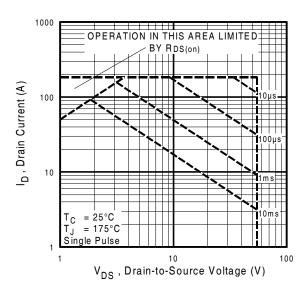
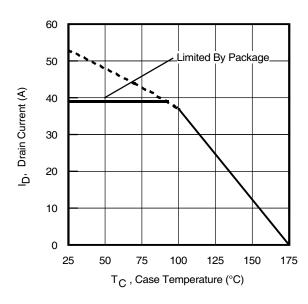


Fig 8. Maximum Safe Operating Area

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†√_{DD}



Pulse Width ≤1 µs
Duty Factor ≤0.1 %

Fig 10a. Switching Time Test Circuit

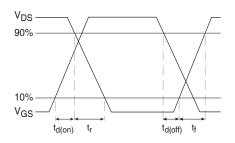


Fig 9. Maximum Drain Current Vs. Case Temperature

Fig 10b. Switching Time Waveforms

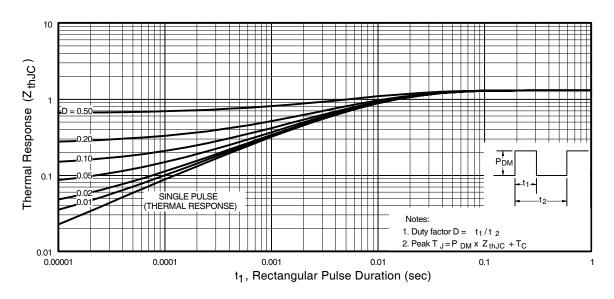


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

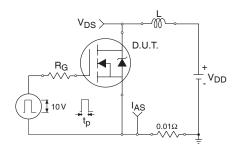


Fig 12a. Unclamped Inductive Test Circuit

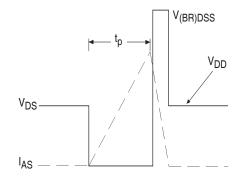


Fig 12b. Unclamped Inductive Waveforms

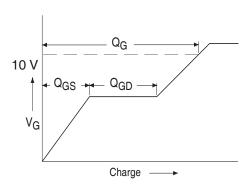


Fig 13a. Basic Gate Charge Waveform

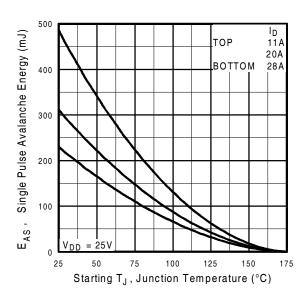


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

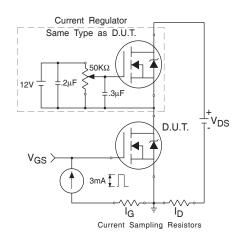
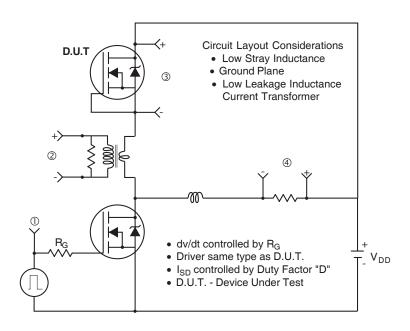
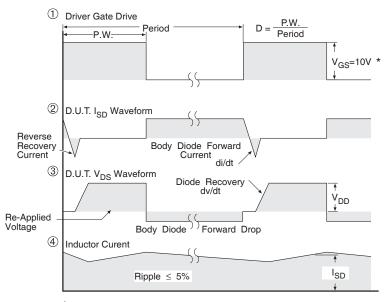


Fig 13b. Gate Charge Test Circuit

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Peak Diode Recovery dv/dt Test Circuit





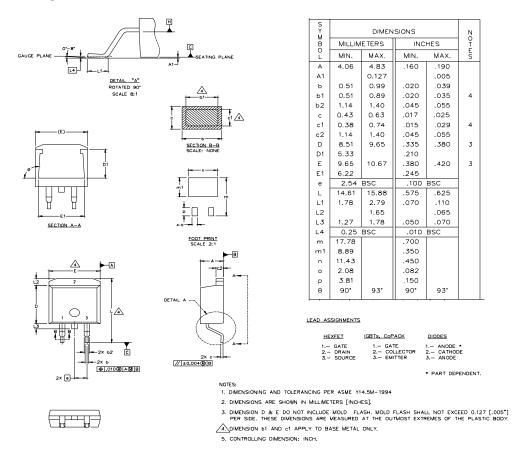
* $V_{GS} = 5V$ for Logic Level Devices

Fig 14. For N-Channel HEXFETS

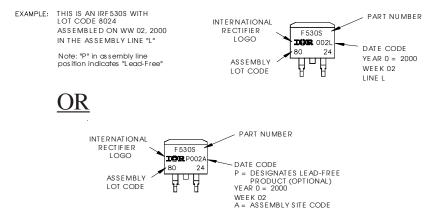
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D²Pak Package Outline



D²Pak Part Marking Information (Lead-Free)

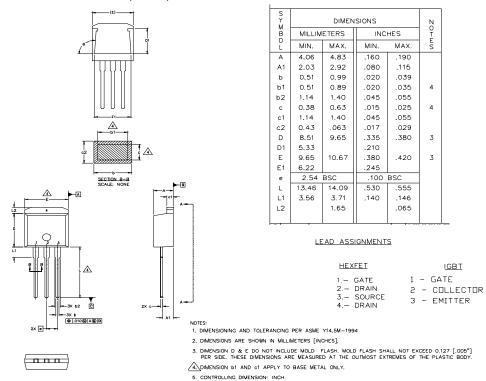


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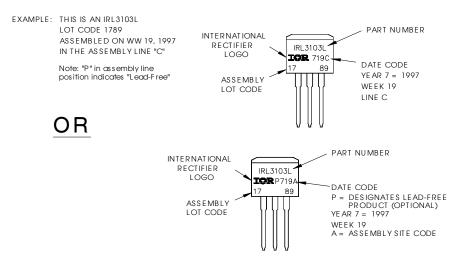
IRFZ46NS/LPbF

TO-262 Package Outline

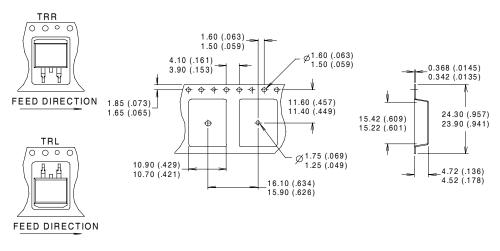
Dimensions are shown in millimeters (inches)

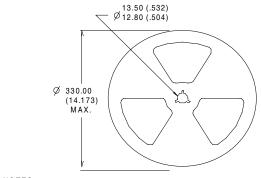


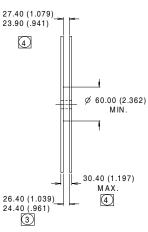
TO-262 Part Marking Information



D²Pak Tape & Reel Information







NOTES:

- 1. COMFORMS TO EIA-418.
 2. CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION MEASURED @ HUB.
 DINCLUDES FLANGE DISTORTION @ OUTER EDGE.

Data and specifications subject to change without notice. This product has been designed and qualified for the industrial market. Qualification Standards can be found on IR's Web site.

International IOR Rectifier

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Visit us at www.irf.com for sales contact information. 4/04

Note: For the most current drawings please refer to the IR website at: http://www.irf.com/package/

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